

Form PTO-1449	U.S. Department of Commerce Patent and Trademark Office	ATTY. DOCKET NO. PB60162B	SERIAL NO. 10/552,494
INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use several sheets if necessary)</i>		APPLICANT Yves St-Denis, et al	
		FILING DATE August 1, 2006	GROUP 1624

U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	5,006,530	4/9/91	Angerbauer, et al. (US Equiv. EP325130)	514	277	
	5,120,782	6/9/92	Hubsch, et al (US Equiv. of EP0465970)	514	300	
	5,169,857	12/8/92	Angerbauer, et al. (US Equiv. of EP325130)	514	344	
	5,378,700	1/3/95	Sakuma, et al. (US Equiv. of WO91/05784A)	514	212	
	5,401,746	3/28/95	Angerbauer, et al. (US Equiv. of EP325130)	514	277	
	5,502,187	3/26/96	Ayer, et al.	544	117	
	5,955,613 A	9/21/99	Horvath et al.	546	87	
	5,962,479 A	10/5/99	Yuhpyng Liang Chen	514	348	
	6,107,301 A	8/22/00	Aldrich et al.	514	258	
	6,133,282	10/17/00	Horvath, et al.	514	292	
	6,355,651	3/12/02	Horvath, et al.	514	292	
	6,436,932 B1	8/20/02	Ge et al.	514	234.5	
	6,525,067 B1	2/25/03	Yuhpyng Chen	514	311	
	US2002111490	8/15/02	Horvath, et al.	546	81	
	US20040176400	9/9/04	Capelli, et al.	514	264.11	
	US2004110785	6/10/04	Wang, et al.	514	300	
	US2004198726A1	10/7/04	DiFabio, et al.	514	230.2	
	US2004235871A1	11/25/04	DiFabio, et al.	514	267	
	US2004242623A1	12/2/04	DiFabio, et al.	514	292	
	US20050054661	3/10/05	DiFabio, et al.	514	265.1	
	US2007021429A1	1/25/07	Yves, St. Denis			
EXAMINER /Cecilia Jaisle/			DATE CONSIDERED 05/19/2008			
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.						

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /C.J./

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		Document Number	Date	Country	Class	Subclass	Translation	
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		EP 325130	1/9/89	EP				
		EP 414767	8/30/90	EP				
		EP 0465970	6/29/91	EP				
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		WO04/094420	11/4/04	PCT				
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		WO 05/063756	7/14/05	PCT				
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